Searcn Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
09/648,590	HAMASHIMA ET AL.
Examiner	Art Unit

2625

Madeleine AV Nguyen

	SEAR	CHED	
Class	Subclass	Date	Examiner
update		1/21/2008	AV

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner

S (INCLUDIN	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
		DATE	EXMR
East		1/21/2008	AV
East		1/22/2008	AV
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